

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/771,825	HASEGAWA, KATSUHIKO	
	Examiner Hwei-Siu C. Payer	Art Unit 3724	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
<u>See Interference</u>			
<u>Search History printout</u>			
10-11-05 Payne			